Application/Control No. 09/344,676 Applicant(s)/Patent Under Reexamination VAN ANTWERP ET AL. Examiner David Lukton Applicant(s)/Patent Under Reexamination VAN ANTWERP ET AL. Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,268,343	07-2001	Knudsen et al.	514/12
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